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December 2013

FCD380N60E

N-Channel SuperFET[®] II Easy-Drive MOSFET 600 V, 10.2 A, 380 m Ω

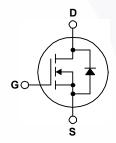
Features

- 650 V @ T_{.1} = 150°C
- Typ. $R_{DS(on)}$ = 320 m Ω
- Ultra Low Gate Charge (Typ. Q_q = 34 nC)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 97 pF)
- · 100% Avalanche Tested
- · An Integrated Gate Resistor
- · RoHS Compliant

Description

SuperFET® II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET easy-drive series offers slightly slower rise and fall times compared to the SuperFET II MOSFET series. Noted by the "E" part number suffix, this family helps manage EMI issues and allows for easier design implementation. For faster switching in applications where switching losses must be at an absolute minimum, please consider the SuperFET II MOSFET series.





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

| Symbol | | Parameter | | FCD380N60E | Unit |
|---|-----------------------------|--|----------|-------------|-------|
| V _{DSS} | Drain to Source Voltage | | | 600 | V |
| V | Cata ta Causaa Maltaga | - DC | | ±20 | V |
| V _{GSS} Gate to Source Voltage | - AC | (f > 1 Hz) | ±30 | V | |
| | Drain Current | - Continuous (T _C = 25°C) | | 10.2 | ^ |
| ID | Drain Current | - Continuous (T _C = 100°C) | | 6.4 | A |
| I _{DM} | Drain Current | - Pulsed | (Note 1) | 30.6 | Α |
| E _{AS} | Single Pulsed Avalanche Ene | Single Pulsed Avalanche Energy (Note 2) | | 211.6 | mJ |
| I _{AR} | Avalanche Current | | (Note 1) | 2.3 | Α |
| E _{AR} | Repetitive Avalanche Energy | | (Note 1) | 1.06 | mJ |
| du/dt | MOSFET dv/dt | | | 100 | V/ns |
| dv/dt | Peak Diode Recovery dv/dt | | (Note 3) | 20 | V/IIS |
| D | Dawas Dissipation | $(T_C = 25^{\circ}C)$ | | 106 | W |
| P_{D} | Power Dissipation | - Derate Above 25°C | | 0.85 | W/°C |
| T _J , T _{STG} | Operating and Storage Temp | Operating and Storage Temperature Range | | -55 to +150 | °C |
| TL | Maximum Lead Temperature | Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds | | | °C |

Thermal Characteristics

| Symbol | Parameter | FCD380N60E | Unit |
|-----------------|---|------------|-------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case, Max. | 1.18 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient, Max. | | *C/VV |

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Package Marking and Ordering Information

| Part Number | Top Mark | Package | Packing Method | Reel Size | Tape Width | Quantity |
|-------------|------------|---------|----------------|-----------|------------|------------|
| FCD380N60E | FCD380N60E | DPAK | Tape and Reel | 330 mm | 16 mm | 2500 units |

Electrical Characteristics T_C = 25°C unless otherwise noted.

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|---|--|--|------|------|------|------|
| Off Charac | cteristics | | | | | |
| D\/ | Drain to Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 25^{\circ}\text{C}$ | 600 | - | - | V |
| BV _{DSS} Drain to Source Breakdown Voltage | Diain to Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 150^{\circ}\text{C}$ | 650 | - | - | V |
| ΔBV _{DSS} / ΔT _J | Breakdown Voltage Temperature Coefficient | I _D = 10 mA, Referenced to 25°C | - | 0.67 | - | V/°C |
| BV _{DS} | Drain to Source Avalanche Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 10 \text{ A}$ | - | 700 | - | V |
| 1 | Zero Gate Voltage Drain Current | $V_{DS} = 480 \text{ V}, V_{GS} = 0 \text{ V}$ | - | - | 5 | ^ |
| IDSS | Zeio Gate Voltage Dialii Cuiteiti | $V_{DS} = 480 \text{ V}, T_{C} = 125^{\circ}\text{C}$ | - | - | 20 | μА |
| I _{GSS} | Gate to Body Leakage Current | V _{GS} = ±20 V, V _{DS} = 0 V | - | - | ±100 | nA |

On Characteristics

| V _{GS(th)} | Gate Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \mu A$ | 2.5 | - | 3.5 | V |
|---------------------|--------------------------------------|--|-----|------|------|---|
| R _{DS(on)} | Static Drain to Source On Resistance | $V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$ | - | 0.32 | 0.38 | Ω |
| 9 _{FS} | Forward Transconductance | $V_{DS} = 20 \text{ V}, I_{D} = 5 \text{ A}$ | - | 10 | - | S |

Dynamic Characteristics

| - | | | | | | |
|------------------------|-------------------------------|--|-----|------|------|----|
| C _{iss} | Input Capacitance | V 05.V.V 0.V | - \ | 1330 | 1770 | pF |
| C _{oss} | Output Capacitance | $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$ | - | 945 | 1260 | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 - 1 1/11/12 | - | 60 | 90 | pF |
| C _{oss} | Output Capacitance | V _{DS} = 380 V, V _{GS} = 0 V, f = 1 MHz | - | 25 | - | pF |
| C _{oss(eff.)} | Effective Output Capacitance | V _{DS} = 0 V to 480 V, V _{GS} = 0 V | - | 97 | - | pF |
| Q _{g(tot)} | Total Gate Charge at 10V | V _{DS} = 380 V, I _D = 5 A, | - | 34 | 45 | nC |
| Q _{gs} | Gate to Source Gate Charge | V _{GS} = 10 V | - | 5.3 | - | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | (Note 4) | - | 13 | - | nC |
| ESR | Equivalent Series Resistance | f = 1 MHz | - | 6 | - | Ω |

Switching Characteristics

| t _{d(on)} | Turn-On Delay Time | | - | 17 | 44 | ns |
|---------------------|---------------------|--|---|----|-----|----|
| t _r | | $V_{DD} = 380 \text{ V}, I_D = 5 \text{ A},$ | - | 9 | 28 | ns |
| t _{d(off)} | Turn-Off Delay Time | $V_{GS} = 10 \text{ V}, R_G = 4.7 \Omega$ | - | 64 | 138 | ns |
| t _f | Turn-Off Fall Time | (Note 4) | - | 10 | 30 | ns |

Drain-Source Diode Characteristics

| I _S | Maximum Continuous Drain to Source Diod | Maximum Continuous Drain to Source Diode Forward Current | | | 10.2 | Α |
|-----------------|--|--|---|-----|------|----|
| I _{SM} | Maximum Pulsed Drain to Source Diode Forward Current | | - | - | 30.6 | Α |
| V_{SD} | Drain to Source Diode Forward Voltage | $V_{GS} = 0V, I_{SD} = 5 A$ | - | - | 1.2 | V |
| t _{rr} | Reverse Recovery Time | $V_{GS} = 0V, I_{SD} = 5 A,$ | - | 240 | | ns |
| Q _{rr} | Reverse Recovery Charge | $dI_F/dt = 100 A/\mu s$ | - | 3 | - | μС |

Notes

- 1. Repetitive rating: pulse-width limited by maximum junction temperature.
- 2. I_{AS} = 2.3 A, V_{DD} = 50 V, R_G = 25 Ω , starting T_J = 25°C.
- 3. I $_{SD}$ \leq 5.1 A, di/dt \leq 200 A/ μ s, V $_{DD}$ \leq BV $_{DSS}$, starting T $_{J}$ = 25°C.
- ${\bf 4.} \ {\bf Essentially independent \ of \ operating \ temperature \ typical \ characteristics.}$

Typical Performance Characteristics

Figure 1. On-Region Characteristics

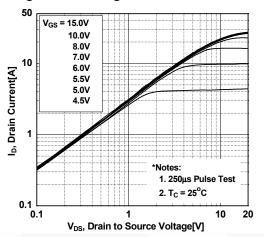


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

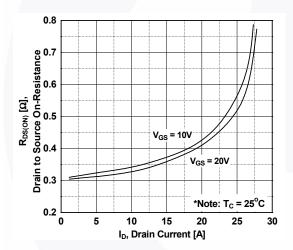


Figure 5. Capacitance Characteristics

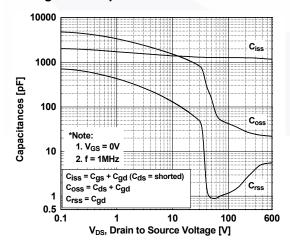


Figure 2. Transfer Characteristics

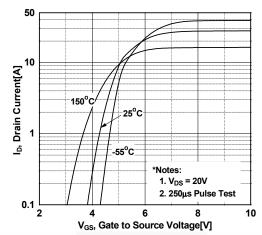


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

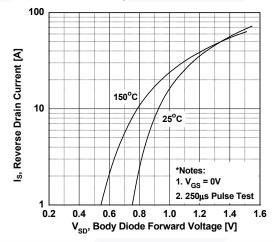
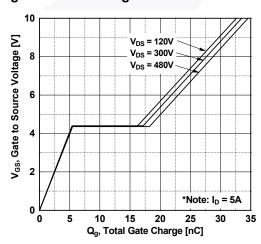


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

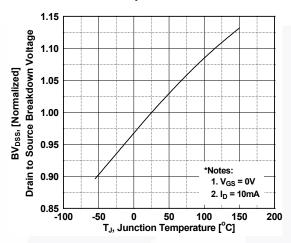


Figure 9. Maximum Safe Operating Area

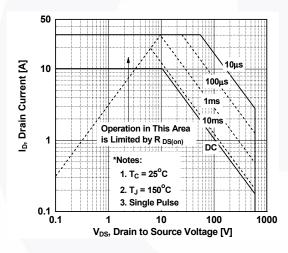


Figure 11. Eoss vs. Drain to Source Voltage

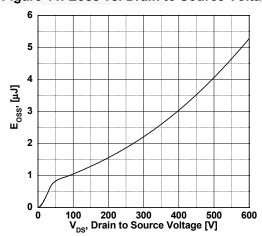


Figure 8. On-Resistance Variation vs. Temperature

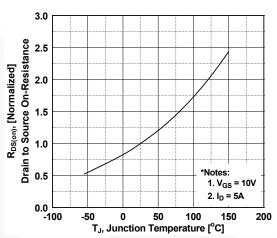
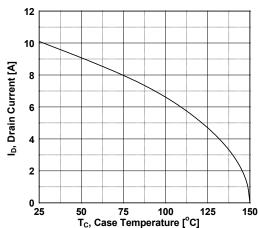


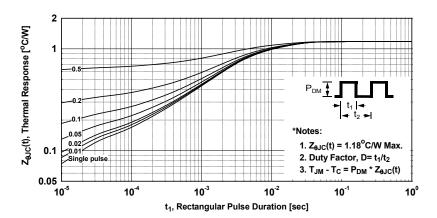
Figure 10. Maximum Drain Current vs. Case Temperature



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Typical Performance Characteristics (Continued)

Figure 12. Transient Thermal Response Curve



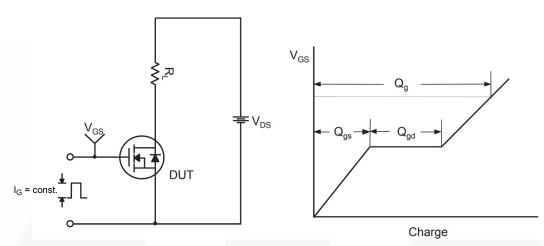


Figure 13. Gate Charge Test Circuit & Waveform

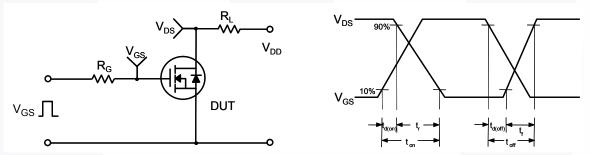


Figure 14. Resistive Switching Test Circuit & Waveforms

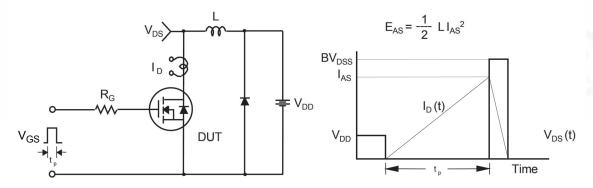


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

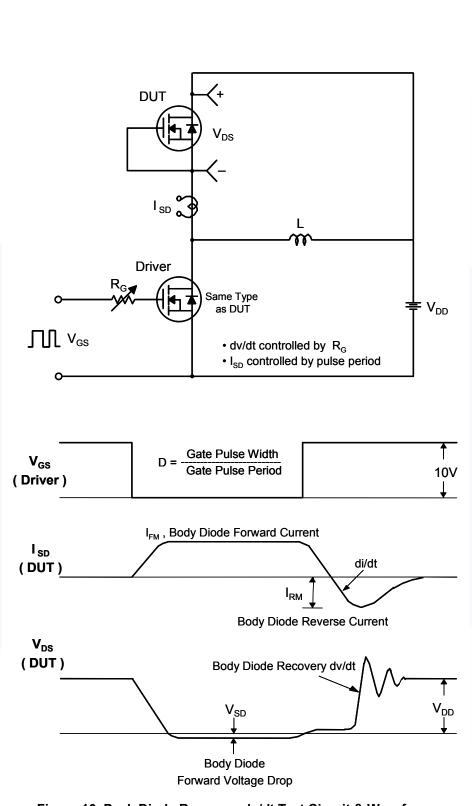


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms

Mechanical Dimensions

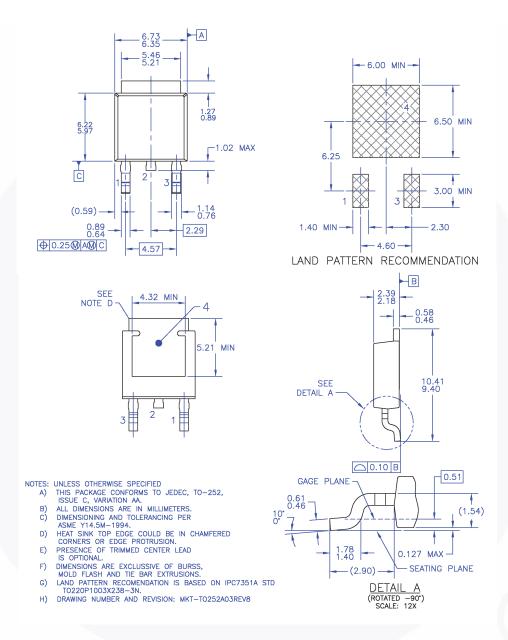


Figure 17. TO252 (D-PAK), Molded, 3-Lead, Option AA&AB

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